



LPDDR4X Datasheet

RS4G32LR4D8BNR-46BT
200-ball

Revision 1.0

Nov. 21. 2024

This document and all information provided herein (collectively, "Information") remains the sole and exclusive property of RAYSON. You must keep all Information in strict confidence and trust, and must not, directly or indirectly, in any way, disclose, make accessible, post on the internet, reveal, report, publish, disseminate or transfer any Information to any third party. You must not reproduce or copy Information, without first obtaining express written permission from RAYSON. You must not use, or allow use of, any Information in any manner whatsoever, except to internally evaluate the information. You must restrict access to Information to those of your employees who have a bonafide need-to-know for such purpose and are bound by obligations at least as restrictive as this clause. In order to receive Information, you must agree to the foregoing and to indemnify RAYSON for any failure to strictly comply therewith. If you do not agree, please do not accept any receipt of Information.

Revision History

Version	Date	Changes
V1.0	2024-11-21	Basic spec and architecture

Notes: This data sheet contains minimum and maximum limits specified over the power supply and temperature range set forth herein. Although considered final, these specifications are subject to change at any time without notice, as further product development and data characterization sometimes occur.

Contents

1. Product Overview	4
1.1. Feature Overview	4
2. Physical Specifications	5
2.1. Function Block Diagram	5
2.2. Package ballout & Addressing	6
2.3. Pad Definition	7
2.4. Discrete Package Dimension	9
3. Core Specifications	10
3.1. Part Number Decoding	10
3.2. Ordering Options	11
3.3. Die Addressing Table	12
3.4. Mode Register Contens	13

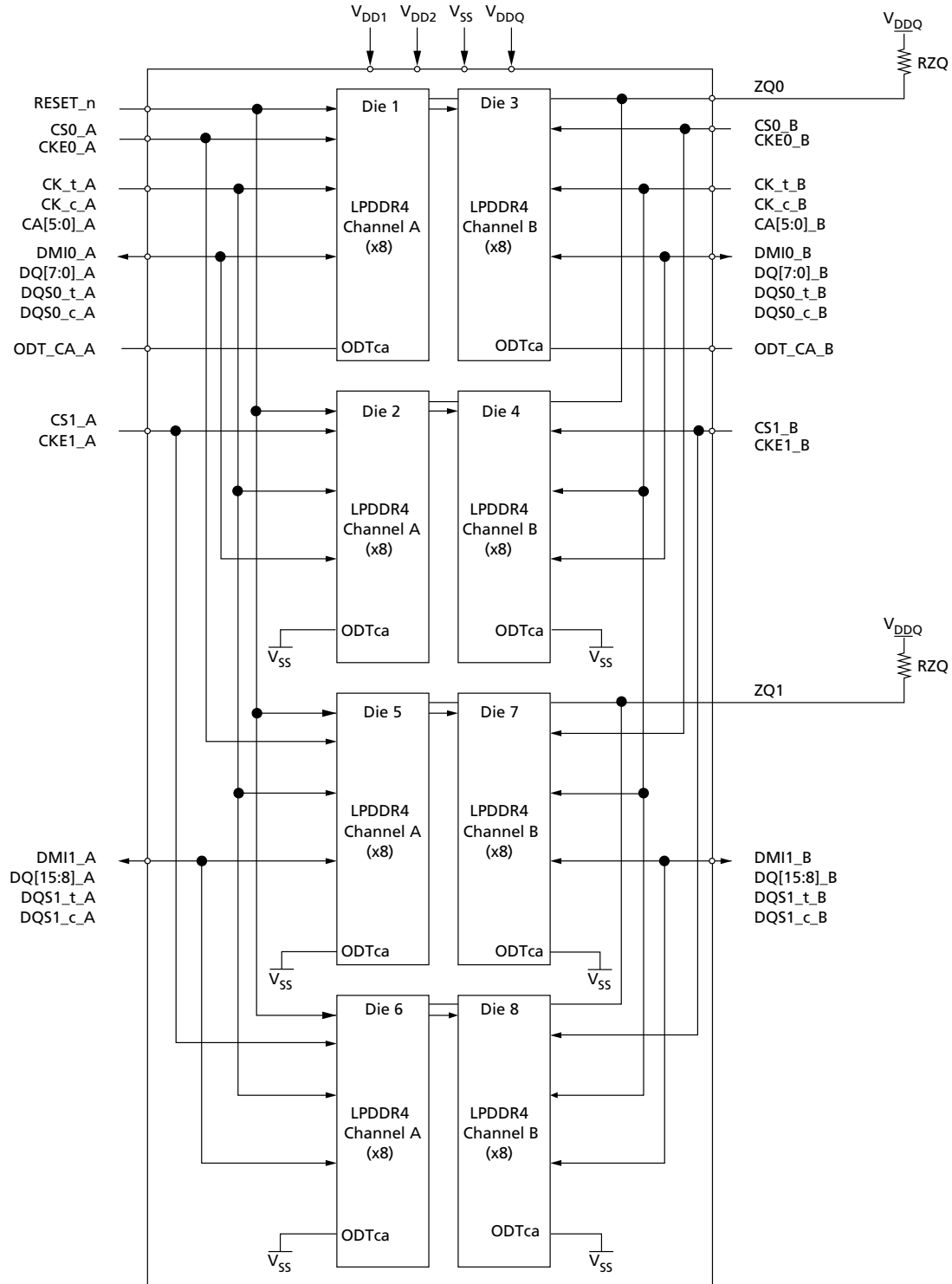
1. Product Overview

1.1. Feature Overview

- Ultra-low-voltage core and I/O power supplies
 - V_{DD1} = 1.70-1.95V; 1.80V nominal
 - V_{DD2} = 1.06-1.17V; 1.10V nominal
 - V_{DDQ} = 0.57-0.65V; 0.60V nominal
- Frequency range
 - 2133-10 MHz (data rate range per pin:4266-20Mbps)
- 16n prefetch DDR architecture
- 8 internal banks per channel for concurrent operation
- Single-data-rate CMD / ADR entry
- Bidirectional / differential data strobe per byte lane
- Programmable READ and WRITE latencies (RL / WL)
- Programmable and on-the-fly burst lengths (BL = 16, 32)
- Directed per-bank refresh for concurrent bank operation and ease of command scheduling
- Up to 8.53 GB / s per die x16 channel
- On-chip temperature sensor to control self refresh rate
- Partial-array self refresh (PASR)
- Selectable output drive strength (DS)
- Clock-stop capability
- RoHS-compliant, “green” packaging
- $V_{DD1}/V_{DD2}/V_{DDQ}$: 1.80V/1.10V/0.60V
- Array configuration
 - 4G x 32 (2 channels x 16 I/O)
 - 2G8 x 8die in package
- FBGA “green” package
 - 200-ball FBGA (10mm x15mm x1.1mm Max)
- Speed grade,cycle time
 - 468ps@ RL = 36/40
- Operating temperature range
 - -25°C to + 85°C

2. Physical Specifications

2.1. Function Block Diagram



Eight-Die, Dual-Channel, Dual-Rank Package Block Diagram

2.2. Package ballout & Addressing

200-Ball Dual-Channel, Dual-Rank Discrete FBGA

	1	2	3	4	5	6	7	8	9	10	11	12
A	DNU	DNU	V _{SS}	V _{DD2}	ZQ0			ZQ1	V _{DD2}	V _{SS}	DNU	DNU
B	DNU	DQ0_A	V _{DDQ}	DQ7_A	V _{DDQ}			V _{DDQ}	DQ15_A	V _{DDQ}	DQ8_A	DNU
C	V _{SS}	DQ1_A	DMI0_A	DQ6_A	V _{SS}			V _{SS}	DQ14_A	DMI1_A	DQ9_A	V _{SS}
D	V _{DDQ}	V _{SS}	DQS0_t_A	V _{SS}	V _{DDQ}			V _{DDQ}	V _{SS}	DQS1_t_A	V _{SS}	V _{DDQ}
E	V _{SS}	DQ2_A	DQS0_c_A	DQ5_A	V _{SS}			V _{SS}	DQ13_A	DQS1_c_A	DQ10_A	V _{SS}
F	V _{DD1}	DQ3_A	V _{DDQ}	DQ4_A	V _{DD2}			V _{DD2}	DQ12_A	V _{DDQ}	DQ11_A	V _{DD1}
G	V _{SS}	ODT_CA_A	V _{SS}	V _{DD1}	V _{SS}			V _{SS}	V _{DD1}	V _{SS}	NC	V _{SS}
H	V _{DD2}	CA0_A	CS1_A	CS0_A	V _{DD2}			V _{DD2}	CA2_A	CA3_A	CA4_A	V _{DD2}
J	V _{SS}	CA1_A	V _{SS}	CKE0_A	CKE1_A			CK_t_A	CK_c_A	V _{SS}	CA5_A	V _{SS}
K	V _{DD2}	V _{SS}	V _{DD2}	V _{SS}	NC			NC	V _{SS}	V _{DD2}	V _{SS}	V _{DD2}
L												
M												
N	V _{DD2}	V _{SS}	V _{DD2}	V _{SS}	NC			NC	V _{SS}	V _{DD2}	V _{SS}	V _{DD2}
P	V _{SS}	CA1_B	V _{SS}	CKE0_B	CKE1_B			CK_t_B	CK_c_B	V _{SS}	CA5_B	V _{SS}
R	V _{DD2}	CA0_B	CS1_B	CS0_B	V _{DD2}			V _{DD2}	CA2_B	CA3_B	CA4_B	V _{DD2}
T	V _{SS}	ODT_CA_B	V _{SS}	V _{DD1}	V _{SS}			V _{SS}	V _{DD1}	V _{SS}	RESET_n	V _{SS}
U	V _{DD1}	DQ3_B	V _{DDQ}	DQ4_B	V _{DD2}			V _{DD2}	DQ12_B	V _{DDQ}	DQ11_B	V _{DD1}
V	V _{SS}	DQ2_B	DQS0_c_B	DQ5_B	V _{SS}			V _{SS}	DQ13_B	DQS1_c_B	DQ10_B	V _{SS}
W	V _{DDQ}	V _{SS}	DQS0_t_B	V _{SS}	V _{DDQ}			V _{DDQ}	V _{SS}	DQS1_t_B	V _{SS}	V _{DDQ}
Y	V _{SS}	DQ1_B	DMI0_B	DQ6_B	V _{SS}			V _{SS}	DQ14_B	DMI1_B	DQ9_B	V _{SS}
AA	DNU	DQ0_B	V _{DDQ}	DQ7_B	V _{DDQ}			V _{DDQ}	DQ15_B	V _{DDQ}	DQ8_B	DNU
AB	DNU	DNU	V _{SS}	V _{DD2}	V _{SS}			V _{SS}	V _{DD2}	V _{SS}	DNU	DNU
	1	2	3	4	5	6	7	8	9	10	11	12

 LPDDR4_A(Channel A)
 LPDDR4_B(Channel B)
 ZQ,ODT_CA,RESET
 Supply
 Ground

2.3. Pad Definition

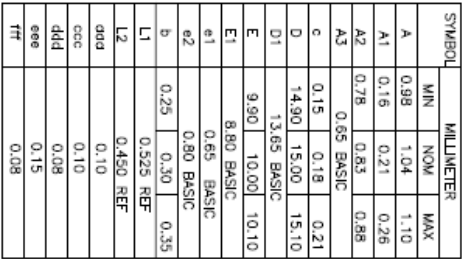
“_A” and “_B” indicate DRAM channels. “_A” pads are present in all devices while “_B” pads are present in dual channel SDRAM devices only.

LPDDR4X pad definitions are the same as LPDDR4, except ODT_CA pins as described in the following Table

Symbol	Type	Description
CK_t_A, CK_c_A CK_t_B, CK_c_B	Input	Clock: CK_t and CK_c are differential clock inputs. All address, command and control input signals are sampled on positive edge of CK_t and the negative edge of CK_c. AC timings for CA parameters are referenced to clock. Each channel (A, B) has its own clock pair.
CKE0_A, CKE1_A CKE0_B, CKE1_B	Input	Clock enable: CKE HIGH activates and CKE LOW deactivates the internal clock signals, input buffers, and output drivers. Power-saving modes are entered and exited via CKE transitions. CKE is sampled at the rising edge of CK.
CS0_A, CS1_A CS0_B, CS1_B	Input	Chip select: Each channel (A, B) has its own CS signals.
CA[5:0]_A CA[5:0]_B	Input	Command/address inputs: Provide the command and address inputs according to the command truth table. Each channel (A, B) has its own CA signals.
DQ[15:0]_A DQ[15:0]_B	I/O	Data input/output: Bidirectional data bus.
DQS[1:0]_t_A DQS[1:0]_c_A DQS[1:0]_t_B DQS[1:0]_c_B	I/O	Data strobe: DQS_t and DQS_c are bi-directional differential output clock signals used to strobe data during a READ or WRITE. The Data Strobe is generated by the DRAM for a READ and is edge-aligned with Data. The Data Strobe is generated by the Memory Controller for a WRITE and must arrive prior to Data. Each byte of data has a Data Strobe signal pair. Each channel (A & B) has its own DQS strobes.
DMI[1:0]_A DMI[1:0]_B	I/O	Data mask inversion: DMI is a bi-directional signal which is driven HIGH when the data on the data bus is inverted, or driven LOW when the data is in its normal state. Data Inversion can be disabled via a mode register setting. Each byte of data has a DMI signal. Each channel (A & B) has its own DMI signals. This signal is also used along with the DQ signals to provide write data masking information to the DRAM. The DMI pin function - Data Inversion or Data mask - depends on Mode Register setting.

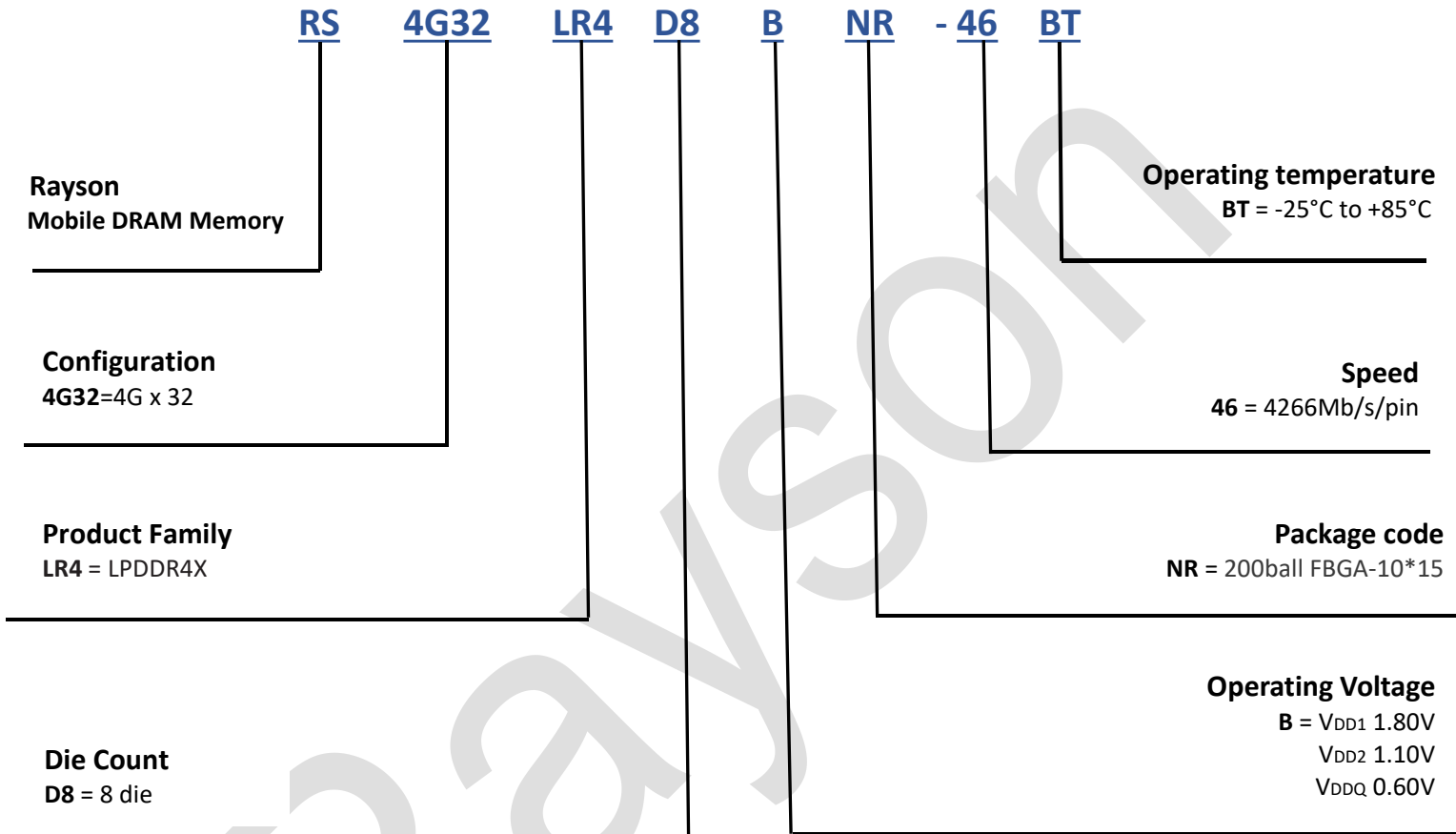
Symbol	Type	Description
ZQ0, ZQ1	Reference	ZQ calibration reference: Used to calibrate the output drive strength and the termination resistance. The ZQ pin shall be connected to V _{DDQ} through a 240Ω ±1% resistor.
V _{DDQ} , V _{DD1} , V _{DD2}	Supply	Power supplies: Isolated on the die for improved noise immunity.
V _{SS} , V _{SSQ}	Supply	Ground reference: Power supply ground reference.
RESET_n	Input	RESET: When asserted LOW, the RESET pin resets all channels of the die.
ODT_CA_A, ODT_CA_B	–	CA ODT Control: LPDDR4X: The ODT_CA pin is ignored by LPDDR4X devices. ODT_CS/CA/CK Function is fully controlled through MR11 and MR22. The ODT_CA pin shall be connected to either VDD2 or Vss.

10mm X 15mm



3. Core Specifications

3.1. Part Number Decoding



3.2. Ordering Options

Table 1: Key Timing Parameters

Speed Grade	Clock Rate (MHz)	Data Rate (Mb/s/pin)	WRITE Latency		READ Latency	
			Set A	Set B	DBI Disabled	DBI Enabled
-46	2133	4266	18	34	36	40

Table 2: Part Number List

Part Number	Total Density	Data Rate	Operating temperature
RS4G32LR4D8BNR-46BT	16GB(128Gb)	4266Mb/s/pin	-25°C to + 85°C

Table 3: Refresh Requirement Parameters

Parameter	Symbol	16Gb Single-Channel Die	unit
REFRESH cycle time (all banks)	^t RFCab	380	ns
REFRESH cycle time (per bank)	^t RFCpb	180	ns
Per bank refresh to per bank refresh time (different bank)	^t PBR2PBR	90	ns

3.3. Die Addressing Table

Configuration		4G32 (128Gb/package)
Die Configuration	Channel A, rank 0, DQ[7:0]_A	× 8 mode × 1 die
	Channel A, rank 1, DQ[7:0]_A	× 8 mode × 1 die
	Channel B, rank 0 , DQ[7:0]_B	× 8 mode × 1 die
	Channel B, rank 1, DQ[7:0]_B	× 8 mode × 1 die
	Channel A, rank 0, DQ[15:8]_A	×8 mode × 1 die
	Channel A, rank 1, DQ[15:8]_A	× 8 mode × 1 die
	Channel B, rank 0, DQ[15:8]_B	×8 mode × 1 die
	Channel B, rank 1, DQ[15:8]_B	× 8 mode × 1 die
Die Addressing	Memory density (per die)	16Gb
	Memory density (per channel)	16Gb
	Configuration	256Mb × 8 DQ × 8 banks x 1channel x1rank
	Number of channels (per die)	1
	Number of ranks per channel	1
	Number of banks (per channel)	8
	Number of rows (per channel)	262,144
	Number of columns (fetch boundaries)	64
	Page size (bytes)	1024
	Channel density (bits per channel)	17,179,869,184
	Total density (bits per die)	17,179,869,184
	Bank address	BA[2:0]
	Row address	R[17:0]
	Column address	C[9:0]
	Burst starting address boundary	64-bit

Notes: 1、 Refer to Package Block Diagrams section in Product specification and SDRAM Addressing Section in General LPDDR4X specification.
2、 Refer to Byte Mode section for further information

3.4. Mode Register Contens

MR0		
OP7		OP[0] = 0b: Both legacy and modified refresh mode supported OP[1] = 0b: Device supports normal latency 1b: Device supports byte more latency
OP6		
OP5		
OP4		
OP3		
OP2		
OP1	Latency Mode	
OP0	REF	

MR5		
OP7	Manufacturer ID	0001 0011b : CX
OP6		
OP5		
OP4		
OP3		
OP2		
OP1		
OP0		

MR6		
OP7	Revision ID1	0000 0000b
OP6		
OP5		
OP4		
OP3		
OP2		
OP1		
OP0		

MR8		
OP7	I/O width	OP[7:6] = 00b: x16/channel
OP6		
OP5	Density	OP[5:2] = 0110b: 16Gb single-channel die
OP4		
OP3		
OP2		
OP1		
OP0		

MR13		
OP7		OP[2] = 0b: Normal operation (default) 1b: Output the $V_{REF(CA)}$ value on DQ7 and $V_{REF(DQ)}$ value on DQ6
OP6		
OP5		
OP4		
OP3		
OP2	VRO	
OP1		
OP0		

MR24		
OP7	TRR Mode	OP[3:0] = 1000b: Unlimited MAC OP[7] = 0b: Disable (default) 1b: Reserved
OP6		
OP5		
OP4		
OP3	Unlimited MAC	
OP2	MAC Value	
OP1		
OP0		

- Notes :**
- 1、 *The contents of MR0, MR[6:5], MR8, MR13 and MR24 will reflect information specific to each in these package*
 - 2、 *Other bits not defined above and other mode registers are referred to in Mode Register Assignments and Definitions section.*

Rayson